











INA225

ZHCSC53A - FEBRUARY 2014-REVISED MARCH 2014

INA225 36V,可编程增益,电压输出, 双向, 电流分流监视器

特性

- 宽共模范围: 0V 至 36V
- 偏移电压: ±150µV (最大值,所有增益)
- 偏移电压漂移: 0.5μV/°C(最大值)
- 温度范围内的增益精度(最大值):
 - 25V/V, 50V/V: ±0.15%
 - 100V/V: ±0.2%
 - 200V/V: ±0.3%
 - − 10ppm/°C 增益漂移
- 250kHz 带宽(增益 = 25V/V)
- 可编辑增益:
 - G1 = 25V/V
 - G2 = 50V/V
 - G3 = 100V/V
 - G4 = 200V/V
- 静态电流: 350µA(最大值)
- 封装: 微型小外形尺寸封装 (MSOP)-8

应用范围

- 电源
- 电机控制
- 计算机
- 电信设备
- 电源管理
- 测试和测量

3 说明

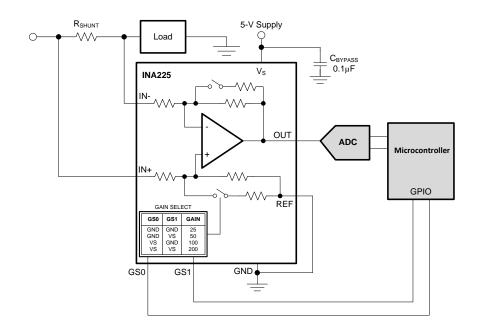
INA225 是一款电压输出、电流感测放大器,此放大器 电流感测电阻器在 0V 至 36V 的共模电压范围内的压 降,此压降与电源电压无关。 此器件是一款双向、电 流分流监视器, 使得外部基准可被用来测量从两个方向 流入电流感测电阻器的电流。

可使用两个增益选择端子(GSO和GS1)来选择四个 离散增益级, 以设定 25V/V, 50V/V, 100V/V 和 200V/V 的增益。这个低偏移、零漂移架构,连同精准 增益值,可实现分流上最大压降低至满量程 10mV 时 的电流感测,而同时又在整个工作温度范围内保持极高 测量精度。

此器件由一个 +2.7V 至 +36V 的单电源供电,汲取 350µA 的最大电源电流。 此器件在扩展工作温度范 围 (-40°C 至 +125°C) 下额定运行, 并采用 MSOP-8 封装。

器件信息

HITTH'C					
订货编号	封装	封装尺寸			
INA225AIDGK	MSOP (8)	3.0mm x 3.0mm			





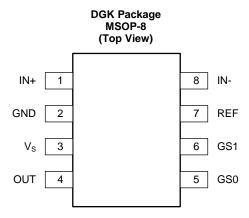
	目表	录		
1	特性1		7.3 Feature Description	
2	应用范围 1		7.4 Device Functional Modes	16
3	说明1	8	Applications and Implementation	19
4	修订历史记录 2		8.1 Application Information	
5	Terminal Configuration and Functions 3		8.2 Typical Applications	19
6	Specifications4	9	Power Supply Recommendations	25
•	6.1 Absolute Maximum Ratings	10	Layout	25
	6.2 Handling Ratings4		10.1 Layout Guidelines	25
	6.3 Recommended Operating Conditions		10.2 Layout Example	
	6.4 Thermal Information	11	器件和文档支持	26
	6.5 Electrical Characteristics		11.1 相关文档	26
	6.6 Typical Characteristics		11.2 Trademarks	26
7	Detailed Description 13		11.3 Electrostatic Discharge Caution	26
-	7.1 Overview		11.4 Glossary	
	7.2 Functional Block Diagram	12	机械封装和可订购信息	26

4 修订历史记录

Cł	nanges from Original (February	/ 2014) to Revision A	Page
•	己对产品预览数据表进行更改。		1



5 Terminal Configuration and Functions



Terminal Functions

TERMINAL		1/0	DESCRIPTION
NAME	NO.	1/0	DESCRIPTION
IN+	1	Analog input	Connect to supply side of shunt resistor.
GND	2	Analog	Ground
V _S	3	Analog	Power supply, 2.7 V to 36 V
OUT	4	Analog output	Output voltage
GS0	5	Digital input	Gain select. Connect to V_S or GND. Table 3 lists terminal settings and the corresponding gain value.
GS1	6	Digital input	Gain select. Connect to V_{S} or GND. Table 3 lists terminal settings and the corresponding gain value.
REF	7	Analog input	Reference voltage, 0 V to V _S
IN-	8	Analog input	Connect to load side of shunt resistor.



6 Specifications

6.1 Absolute Maximum Ratings⁽¹⁾

Over operating free-air temperature range, unless otherwise noted.

		MIN	MAX	UNIT
Supply voltage			+40	V
Analog inputs V (2)	Differential (V _{IN+}) – (V _{IN-})	-40	+40	V
Analog inputs, V _{IN+} , V _{IN-} ⁽²⁾	Common-mode ⁽³⁾	GND - 0.3	+40	V
REF, GS0, and GS1 inputs		GND - 0.3	$(V_S) + 0.3$	V
Output		GND - 0.3	$(V_S) + 0.3$	V
Tomporoturo	Operating, T _A	-55	+150	°C
Temperature	Junction, T _J		+150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

 V_{IN+} and V_{IN-} are the voltages at the IN+ and IN- terminals, respectively.

6.2 Handling Ratings

		MIN	MAX	UNIT
T _{STG}	Storage temperature range	-65	+150	ů
	Human body model (HBM) stress voltage (2)		4	kV
V _{ESD} (')			1	kV

⁽¹⁾ Electrostatic discharge (ESD) to measure device sensitivity and immunity to damage caused by assembly line electrostatic discharges in to the device.

6.3 Recommended Operating Conditions

Over operating free-air temperature range, unless otherwise noted.

		MIN	NOM	MAX	UNIT
V_{CM}	Common-mode input voltage		12		V
Vs	Operating supply voltage		5		V
T _A	Operating free-air temperature	-40		+125	°C

6.4 Thermal Information

		INA225	
	THERMAL METRIC	DGK (MSOP)	UNIT
		8 TERMINALS	
θ_{JA}	Junction-to-ambient thermal resistance	163.6	
θ_{JCtop}	Junction-to-case (top) thermal resistance	57.7	
θ_{JB}	Junction-to-board thermal resistance	84.7	°C/W
ΨЈТ	Junction-to-top characterization parameter	6.5	C/VV
Ψ_{JB}	Junction-to-board characterization parameter	83.2	
θ_{JCbot}	Junction-to-case (bottom) thermal resistance	N/A	

⁽³⁾ Input voltage at any terminal may exceed the voltage shown if the current at that terminal is limited to 5 mA.

⁽²⁾ Level listed above is the passing level per ANSI, ESDA, and JEDEC JS-001. JEDEC document JEP155 states that 4-kV HBM allows safe manufacturing with a standard ESD control process.

⁽³⁾ Level listed above is the passing level per EIA-JEDEC JESD22-C101. JEDEC document JEP157 states that 1-kV CDM allows safe manufacturing with a standard ESD control process.



6.5 Electrical Characteristics

At T_A = +25°C, V_{SENSE} = V_{IN+} – V_{IN-} , V_S = +5 V, V_{IN+} = 12 V, and V_{REF} = V_S / 2, unless otherwise noted.

PAF	RAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
INPUT						
V_{CM}	Common-mode input range	$T_A = -40$ °C to +125°C	0		36	V
CMR	Common-mode rejection	V _{IN+} = 0 V to +36 V, V _{SENSE} = 0 mV, T _A = -40°C to +125°C	95	105		dB
Vos	Offset voltage, RTI ⁽¹⁾	V _{SENSE} = 0 mV		±75	±150	μV
dV _{OS} /dT	RTI vs temperature	$T_A = -40$ °C to +125°C		0.2	0.5	μV/°C
PSRR	Power-supply rejection ratio	V _{SENSE} = 0 mV, V _{REF} = 2.5 V, V _S = 2.7 V to 36 V		±0.1	±1	μV/V
I _B	Input bias current	V _{SENSE} = 0 mV	55	72	85	μA
Ios	Input offset current	V _{SENSE} = 0 mV		±0.5		μA
V_{REF}	Reference input range	$T_A = -40$ °C to +125°C	0		Vs	V
OUTPU	Т					
G	Gain		25,	50, 100, 200		V/V
		Gain = 25 V/V and 50 V/V, V _{OUT} = 0.5 V to V _S - 0.5 V, T _A = -40°C to +125°C		±0.05%	±0.15%	
E_G	Gain error	Gain = 100 V/V, V_{OUT} = 0.5 V to V_S – 0.5 V, T_A = -40°C to +125°C		±0.1%	±0.2%	
		Gain = 200 V/V, V_{OUT} = 0.5 V to V_{S} – 0.5 V, T_{A} = -40°C to +125°C		±0.1%	±0.3%	
	Gain error vs temperature	G = 25 V/V, 50 V/V, 100 V/V, T _A = -40°C to +125°C		3	10	ppm/°C
		G = 200 V/V, T _A = -40°C to +125°C		5	15	
	Nonlinearity error	V _{OUT} = 0.5 V to V _S – 0.5 V		±0.01%		
	Maximum capacitive load	No sustained oscillation		1		nF
VOLTAC	GE OUTPUT ⁽²⁾					
	Swing to V _S power-supply rai	$R_L = 10 \text{ k}\Omega$ to GND, $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$		V _S - 0.05	$V_{S} - 0.2$	V
		$V_{REF} = V_S$ / 2, all gains, $R_L = 10 \text{ k}\Omega$ to GND, $T_A = -40^{\circ}\text{C}$ to +125°C		V _{GND} + 5	V _{GND} + 10	mV
		V_{REF} = GND, gain = 25 V/V, R_L = 10 kΩ to GND, T_A = -40°C to +125°C		V _{GND} + 7		mV
	Swing to GND (3)	V_{REF} = GND, gain = 50 V/V, R_L = 10 kΩ to GND, T_A = -40°C to +125°C		V _{GND} + 15		mV
		V_{REF} = GND, gain = 100 V/V, R_L = 10 k Ω to GND, T_A = -40°C to +125°C		V _{GND} + 30		mV
		V_{REF} = GND, gain = 200 V/V, R_L = 10 k Ω to GND, T_A = -40°C to +125°C		V _{GND} + 60		mV
FREQUE	ENCY RESPONSE					
-		Gain = 25 V/V, C _{LOAD} = 10 pF		250		kHz
D\M	Pandwidth	Gain = 50 V/V, C _{LOAD} = 10 pF		200		kHz
BW	Bandwidth	Gain = 100 V/V, C _{LOAD} = 10 pF		125		kHz
		Gain = 200 V/V, C _{LOAD} = 10 pF		70		kHz
SR	Slew rate			0.4		V/µs
NOISE,	RTI ⁽¹⁾					
	Voltage noise density			50		nV/√ Hz

⁽¹⁾ RTI = referred-to-input.

 ⁽²⁾ See Typical Characteristic curve, Output Voltage Swing vs Output Current (Figure 10).
 (3) See Typical Characteristic curve, Unidirectional Output Voltage Swing vs. Temperature (Figure 14)



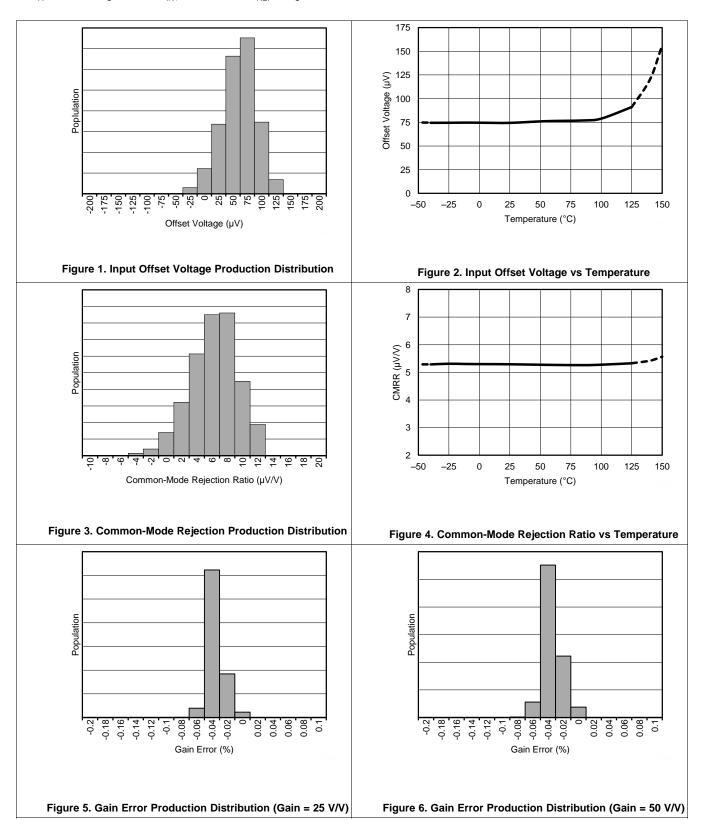
Electrical Characteristics (continued)

At T_A = +25°C, V_{SENSE} = V_{IN+} - V_{IN-} , V_S = +5 V, V_{IN+} = 12 V, and V_{REF} = V_S / 2, unless otherwise noted.

PA	RAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
DIGITA	L INPUT		<u>'</u>			
C _i	Input capacitance			3		pF
	Leakage input current	$0 \le V_{IN} \le V_{S}$		1	2	μΑ
V _{IL}	Low-level input logic level		0		0.6	V
V _{IH}	High-level input logic level		2		Vs	V
POWER	R SUPPLY		·			
Vs	Operating voltage range	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$	+2.7		+36	V
IQ	Quiescent current	V _{SENSE} = 0 mV		300	350	μΑ
	I _Q over temperature	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$			375	μΑ
TEMPE	RATURE RANGE		·			
	Specified range		-40		+125	°C
	Operating range		-55		+150	°C

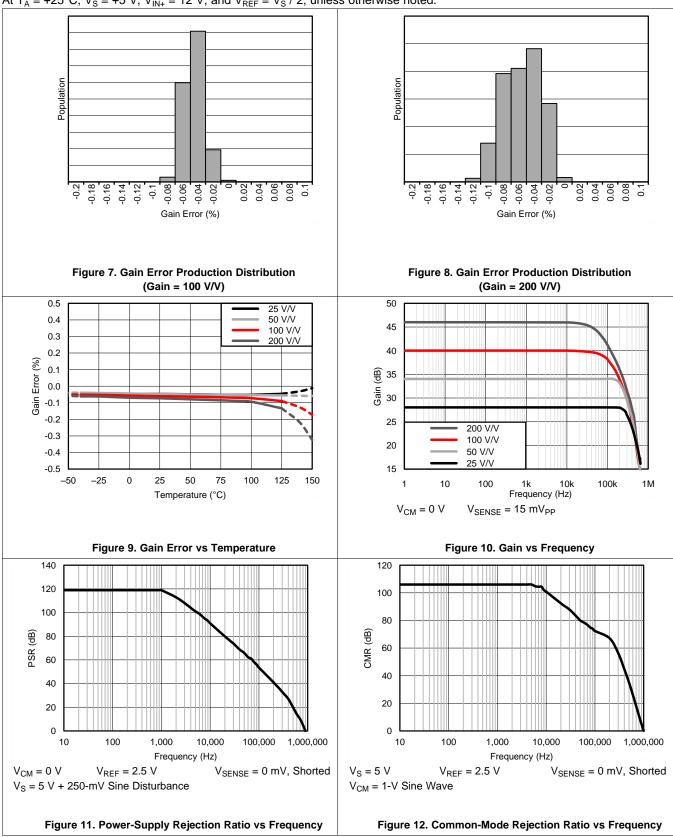


6.6 Typical Characteristics



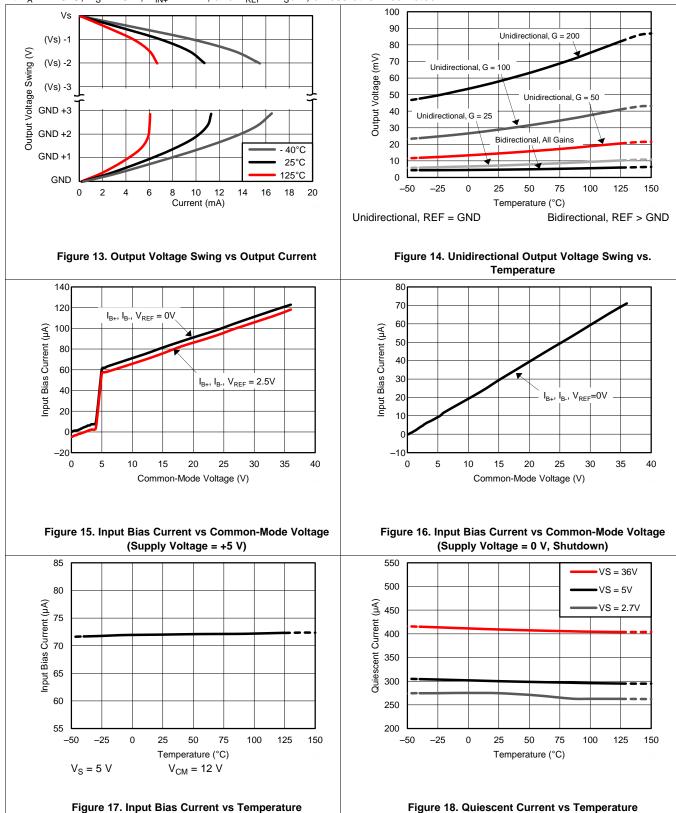
TEXAS INSTRUMENTS

Typical Characteristics (continued)



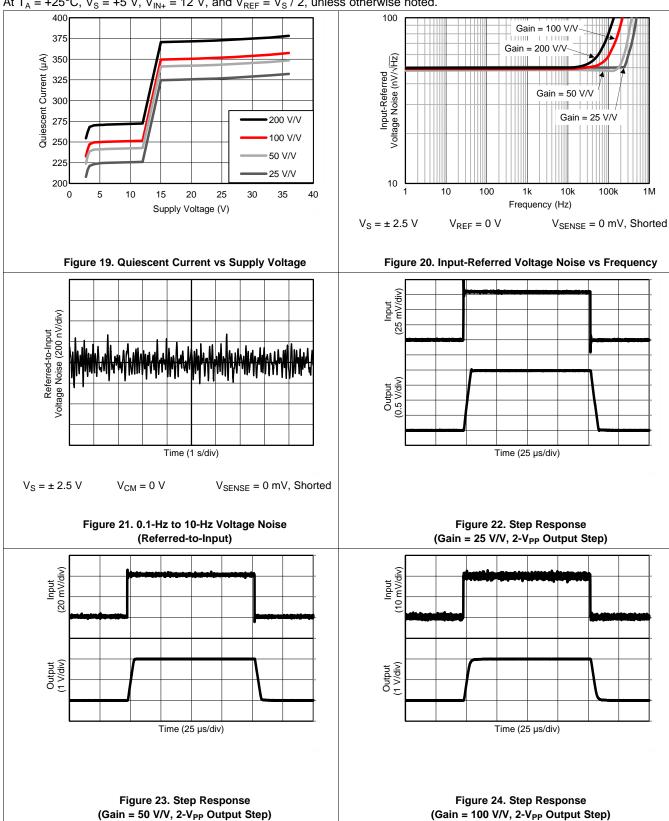


Typical Characteristics (continued)



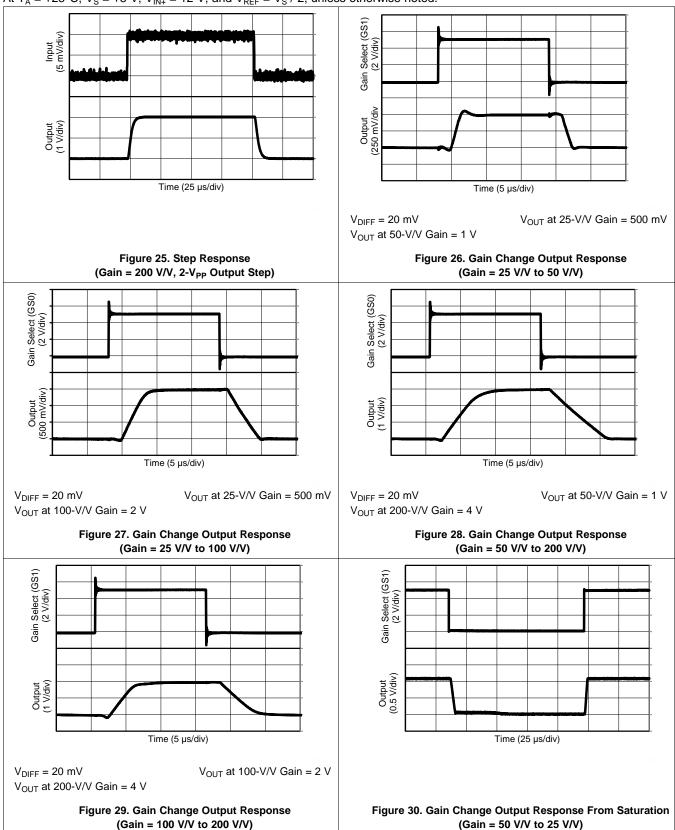
STRUMENTS

Typical Characteristics (continued)



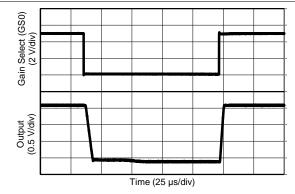


Typical Characteristics (continued)



TEXAS INSTRUMENTS

Typical Characteristics (continued)



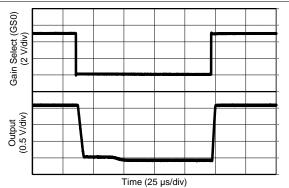
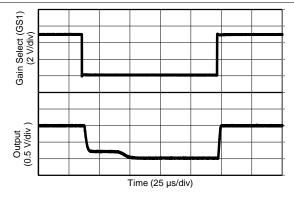


Figure 31. Gain Change Output Response From Saturation (Gain = 100 V/V to 25 V/V)

Figure 32. Gain Change Output Response From Saturation (Gain = 200 V/V to 50 V/V)



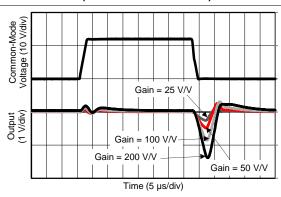


Figure 33. Gain Change Output Response From Saturation (Gain = 200 V/V to 100 V/V)

Figure 34. Common-Mode Voltage Transient Response

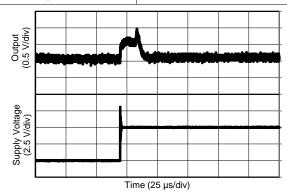


Figure 35. Start-Up Response

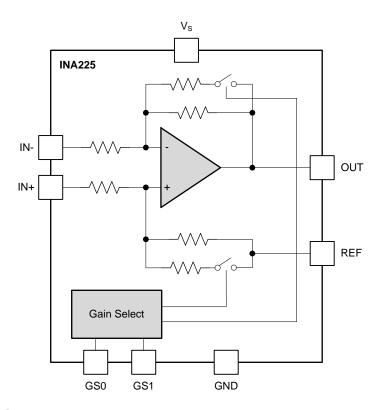


7 Detailed Description

7.1 Overview

The INA225 is a 36-V, common-mode, zero-drift topology, current-sensing amplifier. This device features a significantly higher signal bandwidth than most comparable precision, current-sensing amplifiers, reaching up to 125 kHz at a gain of 100 V/V. A very useful feature present in the device is the built-in programmable gain selection. To increase design flexibility with the device, a programmable gain feature is added that allows changing device gain during operation in order to accurately monitor wider dynamic input signal ranges. Four discrete gain levels (25 V/V, 50 V/V, 100 V/V, and 200 V/V) are available in the device and are selected using the two gain-select terminals, GS0 and GS1.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Selecting A Shunt Resistor

The device measures the differential voltage developed across a resistor when current flows through it. This resistor is commonly referred to as a *current-sensing resistor* or a *current-shunt resistor*, with each term commonly used interchangeably. The flexible design of the device allows a wide range of input signals to be measured across this current-sensing resistor.

Selecting the value of this current-sensing resistor is based primarily on two factors: the required accuracy of the current measurement and the allowable power dissipation across the resistor. The larger the voltage developed across this resistor the more accurate of a measurement that can be made because of the fixed internal amplifier errors. These fixed internal amplifier errors, which are dominated by the internal offset voltage of the device, result in a larger measurement uncertainty when the input signal gets smaller. When the input signal gets larger, the measurement uncertainty is reduced because the fixed errors become a smaller percentage of the signal being measured.



Feature Description (continued)

A system design trade-off for improving the measurement accuracy through the use of the larger input signals is the increase in the power dissipated across the current-sensing resistor. Increasing the value of the current-shunt resistor increases the differential voltage developed across the resistor when current passes through it. However, the power that is then dissipated across this component also increases. Decreasing the value of the current-shunt resistor value reduces the power dissipation requirements of the resistor, but increases the measurement errors resulting from the decreasing input signal. Finding the optimal value for the shunt resistor requires factoring both the accuracy requirement of the application and allowable power dissipation into the selection of the component. An increasing amount of very low ohmic value resistors are becoming available with values reaching down to $200~\mu\Omega$ with power dissipations of up to 5 W, thus enabling very large currents to be accurately monitored using sensing resistors.

The maximum value for the current-sensing resistor that can be chosen is based on the full-scale current to be measured, the full-scale input range of the circuitry following the device, and the device gain selected. The minimum value for the current-sensing resistor is typically a design-based decision because maximizing the input range of the circuitry following the device is commonly preferred. Full-scale output signals that are significantly less than the full input range of the circuitry following the device output can limit the ability of the system to exercise the full dynamic range of system control based on the current measurement.

7.3.1.1 Selecting A Current-Sense Resistor Example

The example in Table 1 is based on a set of application characteristics, including a 10-A full-scale current range and a 4-V full-scale output requirement. The calculations for selecting a current-sensing resistor of an appropriate value are shown in Table 1.

	the contract of the contract o					
	PARAMETER	EQUATION	RESULT			
I _{MAX}	Full-scale current		10 A			
V _{OUT}	Full-scale output voltage		4 V			
Gain	Gain selected	Initial selection based on default gain setting.	25 V/V			
V_{DIFF}	Ideal maximum differential input voltage	V _{Diff} = V _{OUT} / Gain	160 mV			
R _{SHUNT}	Shunt resistor value	$R_{SHUNT} = V_{Diff} / I_{MAX}$	16 mΩ			
P _{RSENSE}	Current-sense resistor power dissipation	R _{SENSE} x I _{MAX} ²	1.6 W			
V _{OS} Error	Offset voltage error	(V _{OS} / V _{DIFF}) x 100	0.094%			

Table 1. Calculating the Current-Sense Resistor, R_{SENSE}

7.3.1.2 Optimizing Power Dissipation versus Measurement Accuracy

The example shown in Table 1 results in a maximum current-sensing resistor value of 16 m Ω to develop the 160 mV required to achieve the 4-V full-scale output with the gain set to 25 V/V. The power dissipated across this 16-m Ω resistor at the 10-A current level is 1.6 W, which is a fairly high power dissipation for this component. Adjusting the device gain allows alternate current-sense resistor values to be selected to ease the power dissipation requirement of this component.



Changing the gain setting from 25 V/V to 100 V/V, as shown in Table 2, decreases the maximum differential input voltage from 160 mV down to 40 mV, thus requiring only a 4-m Ω current-sensing resistor to achieve the 4-V output at the 10-A current level. The power dissipated across this resistor at the 10-A current level is 400 mW, significantly increasing the availability of component options to select from.

The increase in gain by a factor of four reduces the power dissipation requirement of the current-sensing resistor by this same factor of four. However, with this smaller full-scale signal, the measurement uncertainty resulting from the device fixed input offset voltage increases by the same factor of four. The measurement error resulting from the device input offset voltage is approximately 0.1% at the 160-mV full-scale input signal for the 25-V/V gain setting. Increasing the gain to 100 V/V and decreasing the full-scale input signal to 40 mV increases the offset induced measurement error to 0.38%.

Table 2. Accuracy and $R_{\mbox{\scriptsize SENSE}}$ Power Dissipation vs Gain Setting

	PARAMETER	EQUATION	RESULT
I _{MAX}	Full-scale current		10 A
V _{OUT}	Full-scale output voltage		4 V
Gain	Gain selected		100 V/V
V_{DIFF}	Ideal maximum differential input voltage	V _{Diff} = V _{OUT} / Gain	40 mV
R _{SENSE}	Current-sense resistor value	$R_{SENSE} = V_{Diff} / I_{MAX}$	4 mΩ
P _{RSENSE}	Current-sense resistor power dissipation	R _{SENSE} x I _{MAX} ²	0.4 W
V _{OS} Error	Offset voltage error	(V _{OS} / V _{DIFF}) x 100	0.375%

7.3.2 Programmable Gain Select

The device features a terminal-controlled gain selection in determining the device gain setting. Four discrete gain options are available (25 V/V, 50 V/V, 100 V/V, and 200 V/V) on the device and are selected based on the voltage levels applied to the gain-select terminals (GS0 and GS1). These terminals are typically fixed settings for most applications but the programmable gain feature can be used to adjust the gain setting to enable wider dynamic input range monitoring as well as to create an automatic gain control (AGC) network.

Table 3 shows the corresponding gain values and gain-select terminal values for the device.

Table 3. Gain Select Settings

GAIN	GS0	GS1
25 V/V	GND	GND
50 V/V	GND	V _S
100 V/V	V _S	GND
200 V/V	V _S	V _S

7.4 Device Functional Modes

7.4.1 Input Filtering

An obvious and straightforward location for filtering is at the device output; however, this location negates the advantage of the low output impedance of the internal buffer. The input then represents the best location for implementing external filtering. Figure 36 shows the typical implementation of the input filter for the device.

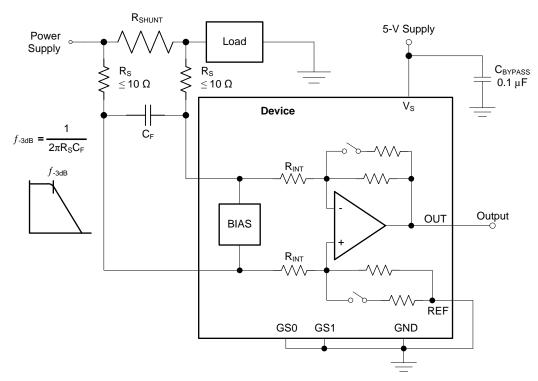


Figure 36. Input Filter

Care must be taken in the selection of the external filter component values because these components can affect device measurement accuracy. Placing external resistance in series with the input terminals creates an additional error so these resistors should be kept as low of a value as possible with a recommended maximum value of 10 Ω or less. Increasing the value of the input filter resistance beyond 10 Ω results in a smaller voltage signal present at the device input terminals than what is developed across the current-sense shunt resistor.

The internal bias network shown in Figure 36 creates a mismatch in the two input bias current paths when a differential voltage is applied between the input terminals. Under normal conditions, where no external resistance is added to the input paths, this mismatch of input bias currents has little effect on device operation or accuracy. However, when additional external resistance is added (such as for input filtering), the mismatch of input bias currents creates unequal voltage drops across these external components. The mismatched voltages result in a signal reaching the input terminals that is lower in value than the signal developed directly across the current-sensing resistor.

The amount of variance in the differential voltage present at the device input relative to the voltage developed at the shunt resistor is based both on the external series resistance value (R_S) and the internal input resistors (R_{INT}). The reduction of the shunt voltage reaching the device input terminals appears as a gain error when comparing the output voltage relative to the voltage across the shunt resistor. A factor can be calculated to determine the amount of gain error that is introduced by the addition of external series resistance.



Device Functional Modes (continued)

The amount of error these external filter resistors introduce into the measurement can be calculated using the simplified gain error factor in Equation 1, where the gain error factor is calculated with Equation 2.

Gain Error Factor =
$$\frac{50,000}{(41 \times R_S) + 50,000}$$

$$\frac{(1250 \times R_{INT})}{(1250 \times R_S) + (1250 \times R_{INT}) + (R_S \times R_{INT})}$$
(1)

where:

- · R_{INT} is the internal input impedance, and
- R_S is the external series resistance. (2)

For example, using the gain error factor (Equation 1), a $10-\Omega$ series resistance results in a gain error factor of 0.992. The corresponding gain error is then calculated using Equation 3, resulting in a gain error of approximately 0.81% solely because of the external $10-\Omega$ series resistors. Using $100-\Omega$ filter resistors increases this gain error to approximately 7.58% from these resistors alone.

Gain Error (%) =
$$1 - \text{Gain Error Factor}$$
 (3)

7.4.2 Shutting Down the Device

Although the device does not have a shutdown terminal, the low-power consumption allows for the device to be powered from the output of a logic gate or transistor switch that can turn on and turn off the voltage connected to the device power-supply terminal.

However, in current-shunt monitoring applications, there is also a concern for how much current is drained from the shunt circuit in shutdown conditions. Evaluating this current drain involves considering the device simplified schematic in shutdown mode, as shown in Figure 37.

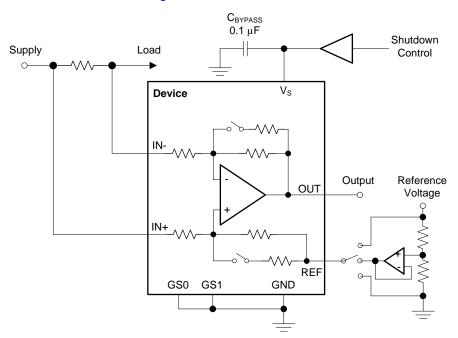


Figure 37. Shutting Down the Device



Device Functional Modes (continued)

Note that there is typically a 525-k Ω impedance (from the combination of the 500-k Ω feedback and 25-k Ω input resistors) from each device input to the REF terminal. The amount of current flowing through these terminals depends on the respective configuration. For example, if the REF terminal is grounded, calculating the effect of the 525-k Ω impedance from the shunt to ground is straightforward. However, if the reference or op amp is powered while the device is shut down, the calculation is direct. Instead of assuming 525 k Ω to ground, assume 525 k Ω to the reference voltage. If the reference or op amp is also shut down, some knowledge of the reference or op amp output impedance under shutdown conditions is required. For instance, if the reference source behaves similar to an open circuit when un-powered, little or no current flows through the 525-k Ω path.

7.4.3 Using the Device with Common-Mode Transients Above 36 V

With a small amount of additional circuitry, the device can be used in circuits subject to transients higher than 36 V (such as automotive applications). Use only zener diodes or zener-type transient absorbers (sometimes referred to as transzorbs); any other type of transient absorber has an unacceptable time delay. Start by adding a pair of resistors, as shown in Figure 38, as a working impedance for the zener. Keeping these resistors as small as possible is preferable, most often around 10 Ω . This value limits the impact on accuracy with the addition of these external components, as described in the Input Filtering section. Larger values can be used if necessary with the result having an impact on gain error. Because this circuit limits only short-term transients, many applications are satisfied with a $10-\Omega$ resistor along with conventional zener diodes of the lowest power rating available. This combination uses the least amount of board space. These diodes can be found in packages as small as SOT-523 or SOD-523.

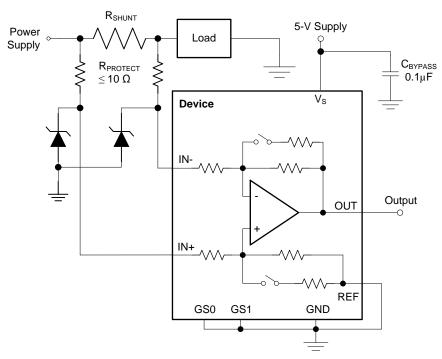


Figure 38. Device Transient Protection



8 Applications and Implementation

8.1 Application Information

The INA225 measures the voltage developed across a current-sensing resistor when current passes through it. The ability to drive the reference terminal to adjust the functionality of the output signal offers multiple configurations discussed throughout this section.

8.2 Typical Applications

8.2.1 Microcontroller-Configured Gain Selection

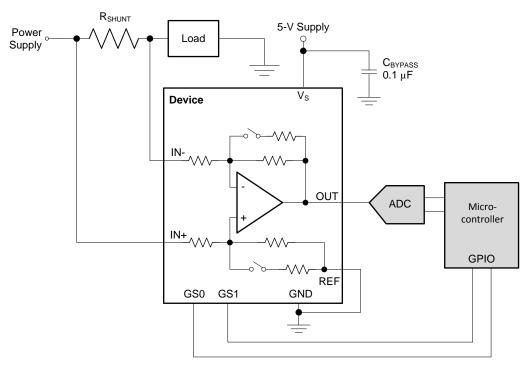


Figure 39. Microcontroller-Configured Gain Selection Schematic

8.2.1.1 Design Requirements

Figure 39 shows the typical implementation of the device interfacing with an analog-to-digital converter (ADC) and microcontroller.

8.2.1.2 Detailed Design Procedure

In this application, the device gain setting is selected and controlled by the microcontroller to ensure the device output is within the linear input range of the ADC. Because the output range of the device under a specific gain setting approaches the linear output range of the INA225 itself or the linear input range of the ADC, the microcontroller can adjust the device gain setting to ensure the signal remains within both the device and the ADC linear signal range.



8.2.1.3 Application Curve

Figure 40 illustrates how the microcontroller can monitor the ADC measurements to determine if the device gain setting should be adjusted to ensure the output of the device remains within the linear output range as well as the linear input range of the ADC. When the output of the device rises to a level near the desired maximum voltage level, the microcontroller can change the GPIO settings connected to the G0 and G1 gain-select terminals to adjust the device gain setting, thus resulting in the output voltage dropping to a lower output range. When the input current increases, the output voltage increases again to the desired maximum voltage level. The microcontroller can again change the device gain setting to drop the output voltage back to a lower range.

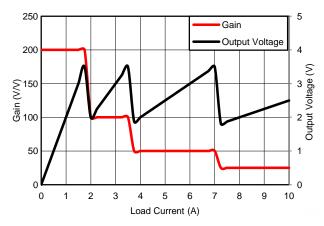


Figure 40. Microcontroller-Configured Gain Selection Response



8.2.2 Unidirectional Operation

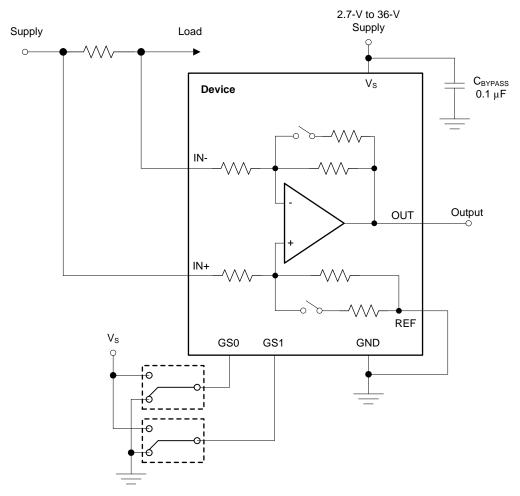


Figure 41. Unidirectional Application Schematic

8.2.2.1 Design Requirements

The device can be configured to monitor current flowing in one direction or in both directions, depending on how the REF terminal is configured. For measuring current in one direction, only the REF terminal is typically connected to ground as shown in Figure 41. With the REF terminal connected to ground, the output is low with no differential input signal applied. When the input signal increases, the output voltage at the OUT terminal increases above ground based on the device gain setting.



8.2.2.2 Detailed Design Procedure

The linear range of the output stage is limited in how close the output voltage can approach ground under zero input conditions. Resulting from an internal node limitation when the REF terminal is grounded (unidirectional configuration) the device gain setting determines how close to ground the device output voltage can achieve when no signal is applied; see Figure 14. To overcome this internal node limitation, a small reference voltage (approximately 10 mV) can be applied to the REF terminal to bias the output voltage above this voltage level. The device output swing capability returns to the 10-mV saturation level with this small reference voltage present.

At the lowest gain setting, 25 V/V, the device is capable of accurately measuring input signals that result in output voltages below this 10-mV saturation level of the output stage. For these gain settings, a reference voltage can be applied to bias the output voltage above this lower saturation level to allow the device to monitor these smaller input signals. To avoid common-mode rejection errors, buffer the reference voltage connected to the REF terminal.

A less frequently-used output biasing method is to connect the REF terminal to the supply voltage, V_S. This method results in the output voltage saturating at 200 mV below the supply voltage when no differential input signal is present. This method is similar to the output saturated low condition with no input signal when the REF terminal is connected to ground. The output voltage in this configuration only responds to negative currents that develop negative differential input voltage relative to the device IN– terminal. Under these conditions, when the differential input signal increases negatively, the output voltage moves downward from the saturated supply voltage. The voltage applied to the REF terminal must not exceed the device supply voltage.

8.2.2.3 Application Curve

An example output response of a unidirectional configuration is shown in Figure 42. With the REF terminal connected directly to ground, the output voltage is biased to this zero output level. The output rises above the reference voltage for positive differential input signals but cannot fall below the reference voltage for negative differential input signals because of the grounded reference voltage.

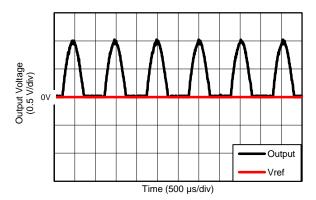


Figure 42. Unidirectional Application Output Response



8.2.3 Bidirectional Operation

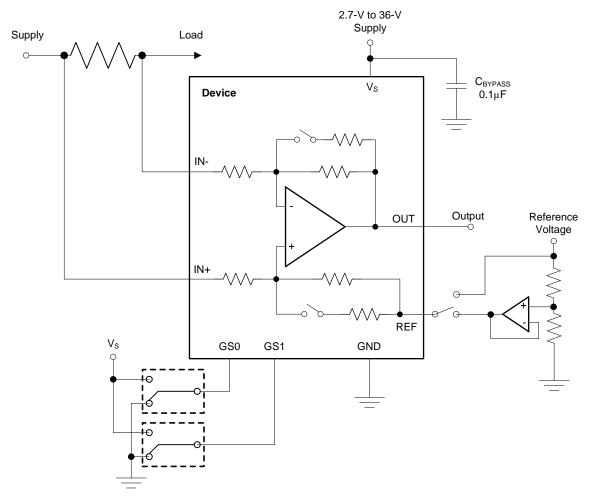


Figure 43. Bidirectional Application Schematic

8.2.3.1 Design Requirements

The device is a bidirectional, current-sense amplifier capable of measuring currents through a resistive shunt in two directions. This bidirectional monitoring is common in applications that include charging and discharging operations where the current flow-through resistor can change directions.

8.2.3.2 Detailed Design Procedure

The ability to measure this current flowing in both directions is enabled by applying a voltage to the REF terminal, as shown in Figure 43. The voltage applied to REF (V_{REF}) sets the output state that corresponds to the zero-input level state. The output then responds by increasing above V_{REF} for positive differential signals (relative to the IN–terminal) and responds by decreasing below V_{REF} for negative differential signals. This reference voltage applied to the REF terminal can be set anywhere between 0 V to V_{S} . For bidirectional applications, V_{REF} is typically set at mid-scale for equal range in both directions. In some cases, however, V_{REF} is set at a voltage other than half-scale when the bidirectional current is non-symmetrical.



8.2.3.3 Application Curve

An example output response of a bidirectional configuration is shown in Figure 44. With the REF terminal connected to a reference voltage, 2.5 V in this case, the output voltage is biased upwards by this reference level. The output rises above the reference voltage for positive differential input signals and falls below the reference voltage for negative differential input signals.

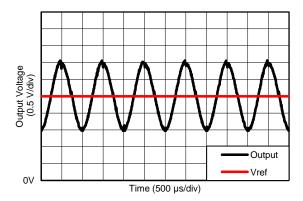


Figure 44. Bidirectional Application Output Response



9 Power Supply Recommendations

The input circuitry of the device can accurately measure signals on common-mode voltages beyond its power supply voltage, V_S . For example, the voltage applied to the V_S power supply terminal can be 5 V, whereas the load power-supply voltage being monitored (the common-mode voltage) can be as high as +36 V. Note also that the device can withstand the full -0.3-V to +36-V range at the input terminals, regardless of whether the device has power applied or not.

Power-supply bypass capacitors are required for stability and should be placed as closely as possible to the supply and ground terminals of the device. A typical value for this supply bypass capacitor is 0.1 μ F. Applications with noisy or high-impedance power supplies may require additional decoupling capacitors to reject power-supply noise.

10 Layout

10.1 Layout Guidelines

- Connect the input terminals to the sensing resistor using a Kelvin or 4-wire connection. This connection technique ensures that only the current-sensing resistor impedance is detected between the input terminals. Poor routing of the current-sensing resistor commonly results in additional resistance present between the input terminals. Given the very low ohmic value of the current resistor, any additional high-current carrying impedance can cause significant measurement errors.
- The power-supply bypass capacitor should be placed as closely as possible to the supply and ground terminals. The recommended value of this bypass capacitor is 0.1 µF. Additional decoupling capacitance can be added to compensate for noisy or high-impedance power supplies.

10.2 Layout Example

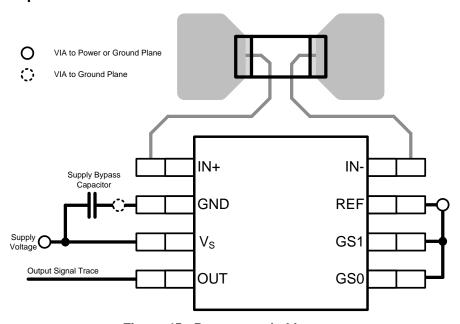


Figure 45. Recommended Layout

NOTE

The layout shown has REF connected to ground for unidirectional operation. Gain-select terminals (GS0 and GS1) are also connected to ground, indicating a 25-V/V gain setting.



11 器件和文档支持

11.1 相关文档

相关文档如下:

• 《INA225EVM 用户指南》, 文献编号: SBOU140

11.2 Trademarks

All trademarks are the property of their respective owners.

11.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms and definitions.

12 机械封装和可订购信息

以下页中包括机械封装和可订购信息。 这些信息是针对指定器件可提供的最新数据。 这些数据会在无通知且不对本文档进行修订的情况下发生改变。 欲获得该数据表的浏览器版本,请查阅左侧的导航栏。

www.ti.com 2-May-2021

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
INA225AIDGKR	ACTIVE	VSSOP	DGK	8	2500	RoHS & Green	NIPDAUAG SN	Level-2-260C-1 YEAR	-40 to 125	B32	Samples
INA225AIDGKT	ACTIVE	VSSOP	DGK	8	250	RoHS & Green	NIPDAUAG SN	Level-2-260C-1 YEAR	-40 to 125	B32	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE OPTION ADDENDUM

www.ti.com 2-May-2021

OTHER QUALIFIED VERSIONS OF INA225:

Automotive : INA225-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

www.ti.com 20-Feb-2022

TAPE AND REEL INFORMATION





		Dimension designed to accommodate the component width
E	30	Dimension designed to accommodate the component length
K	(0	Dimension designed to accommodate the component thickness
	Ν	Overall width of the carrier tape
F	21	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

All difficultions are nomina	I											
Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
INA225AIDGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
INA225AIDGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
INA225AIDGKT	VSSOP	DGK	8	250	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
INA225AIDGKT	VSSOP	DGK	8	250	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

www.ti.com 20-Feb-2022



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
INA225AIDGKR	VSSOP	DGK	8	2500	366.0	364.0	50.0
INA225AIDGKR	VSSOP	DGK	8	2500	366.0	364.0	50.0
INA225AIDGKT	VSSOP	DGK	8	250	366.0	364.0	50.0
INA225AIDGKT	VSSOP	DGK	8	250	366.0	364.0	50.0

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.



DGK (S-PDSO-G8)

PLASTIC SMALL OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



重要声明和免责声明

TI"按原样"提供技术和可靠性数据(包括数据表)、设计资源(包括参考设计)、应用或其他设计建议、网络工具、安全信息和其他资源,不保证没有瑕疵且不做出任何明示或暗示的担保,包括但不限于对适销性、某特定用途方面的适用性或不侵犯任何第三方知识产权的暗示担保。

这些资源可供使用 TI 产品进行设计的熟练开发人员使用。您将自行承担以下全部责任:(1) 针对您的应用选择合适的 TI 产品,(2) 设计、验证并测试您的应用,(3) 确保您的应用满足相应标准以及任何其他功能安全、信息安全、监管或其他要求。

这些资源如有变更,恕不另行通知。TI 授权您仅可将这些资源用于研发本资源所述的 TI 产品的应用。严禁对这些资源进行其他复制或展示。您无权使用任何其他 TI 知识产权或任何第三方知识产权。您应全额赔偿因在这些资源的使用中对 TI 及其代表造成的任何索赔、损害、成本、损失和债务,TI 对此概不负责。

TI 提供的产品受 TI 的销售条款或 ti.com 上其他适用条款/TI 产品随附的其他适用条款的约束。TI 提供这些资源并不会扩展或以其他方式更改 TI 针对 TI 产品发布的适用的担保或担保免责声明。

TI 反对并拒绝您可能提出的任何其他或不同的条款。

邮寄地址:Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2022,德州仪器 (TI) 公司